

SEMITOP[®] 3

IGBT Module

SK75GARL065E

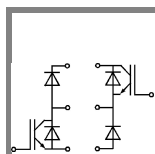
Preliminary Data

Features

- Compact design
- One screw mounting
- Heat transfer and isolation through direct copper bonded aluminium oxide ceramic (DCB)
- N-channel homogeneous silicon structure (NPT-Non punch-through IGBT)
- High short circuit capability
- Low tail current with low temperature dependence

Typical Applications

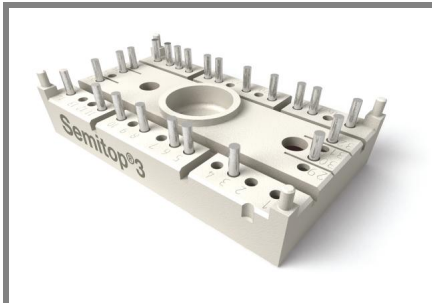
- Switching (not for linear use)
- Switched mode power supplies
- UPS
- Double PFC
- Multilevel inverter



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Absolute Maximum Ratings		$T_s = 25\text{ °C}$, unless otherwise specified		
Symbol	Conditions	Values		Units
IGBT				
V_{CES}	$T_j = 25\text{ °C}$	600		V
I_C	$T_j = 125\text{ °C}$	$T_s = 25\text{ °C}$	80	A
		$T_s = 80\text{ °C}$	55	A
I_{CRM}	$I_{CRM} = 2 \times I_{Cnom}$	180		A
V_{GES}		± 20		V
t_{psc}	$V_{CC} = 300\text{ V}; V_{GE} \leq 20\text{ V}; T_j = 125\text{ °C}$ $V_{CES} < 600\text{ V}$	10		µs
Inverse Diode				
I_F	$T_j = 150\text{ °C}$	$T_s = 25\text{ °C}$	57	A
		$T_s = 80\text{ °C}$	38	A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$			A
I_{FSM}	$t_p = 10\text{ ms}; \text{half sine wave } T_j = 150\text{ °C}$	440		A
Freewheeling Diode				
I_F	$T_j = 150\text{ °C}$	$T_{case} = 25\text{ °C}$	103	A
		$T_{case} = 80\text{ °C}$	69	A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$			A
I_{FSM}	$t_p = 10\text{ ms}; \text{half sine wave } T_j = 150\text{ °C}$	880		A
Module				
$I_{t(RMS)}$				A
T_{vj}		-40 ... +150		°C
T_{stg}		-40 ... +125		°C
V_{isol}	AC, 1 min.	2500		V

Characteristics		$T_s = 25\text{ °C}$, unless otherwise specified				
Symbol	Conditions	min.	typ.	max.	Units	
IGBT						
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 2,1\text{ mA}$	3	4	5	V	
I_{CES}	$V_{GE} = 600\text{ V}, V_{CE} = V_{CES} T_j = 25\text{ °C}$			0,0066	mA	
I_{GES}	$V_{CE} = 0\text{ V}, V_{GE} = 20\text{ V } T_j = 25\text{ °C}$			360	nA	
V_{CE0}		$T_j = 25\text{ °C}$	1,2	1,3	V	
		$T_j = 125\text{ °C}$	1,1	0,9	V	
r_{CE}	$V_{GE} = 15\text{ V}$	$T_j = 25\text{ °C}$			7,7	mΩ
		$T_j = 125\text{ °C}$			14	mΩ
$V_{CE(sat)}$	$I_{Cnom} = 90\text{ A}, V_{GE} = 15\text{ V}$	$T_j = 25\text{ °C}_{chiplev.}$	1,7	2	V	
		$T_j = 125\text{ °C}_{chiplev.}$	2,2	2,2	V	
C_{ies}	$V_{CE} = 25, V_{GE} = 0\text{ V} \quad f = 1\text{ MHz}$			4,8	nF	
C_{oes}				0,45	nF	
C_{res}				0,27	nF	
Q_G	$V_{GE} = 0 \dots 20\text{ V}$			750	nC	
$t_{d(on)}$	$R_{Gon} = 13\text{ } \Omega$	$V_{CC} = 300\text{ V}$ $I_{Cnom} = 100\text{ A}$			54	ns
t_r					58	ns
E_{on}	$R_{Goff} = 13\text{ } \Omega$	$T_j = 125\text{ °C}$ $V_{GE} = \pm 15\text{ V}$			2,71	mJ
$t_{d(off)}$					410	ns
t_f					36	ns
E_{off}					2,75	mJ
$R_{th(j-s)}$	per IGBT			0,6	K/W	



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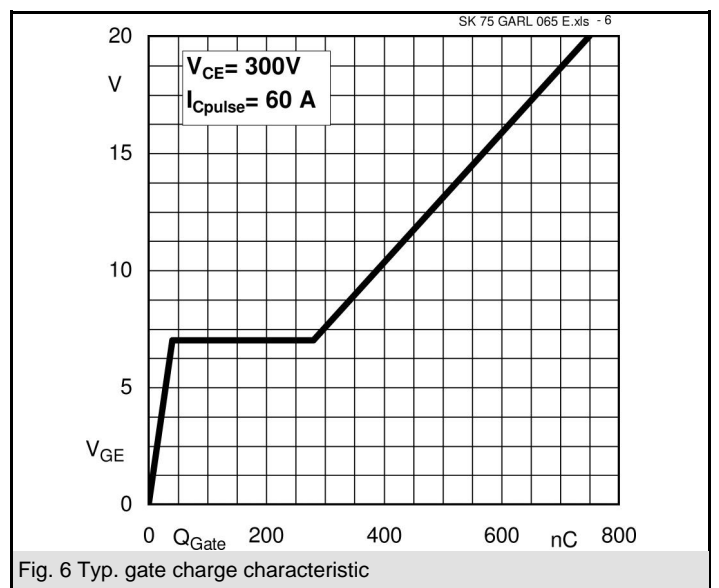
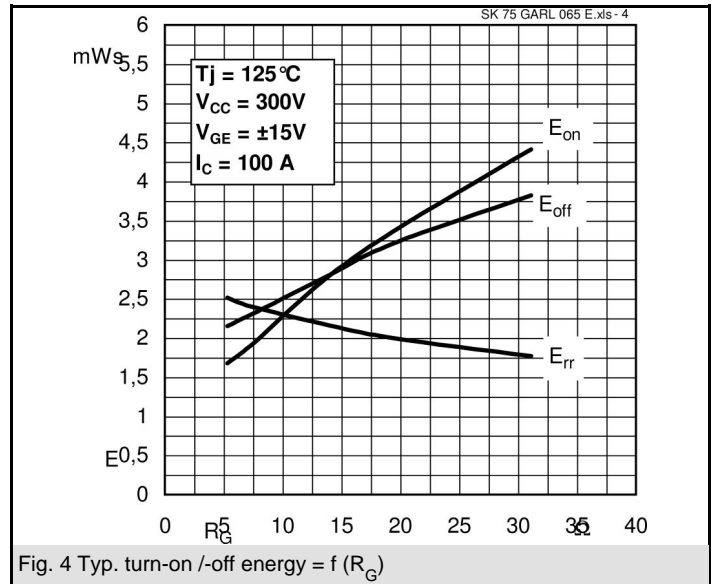
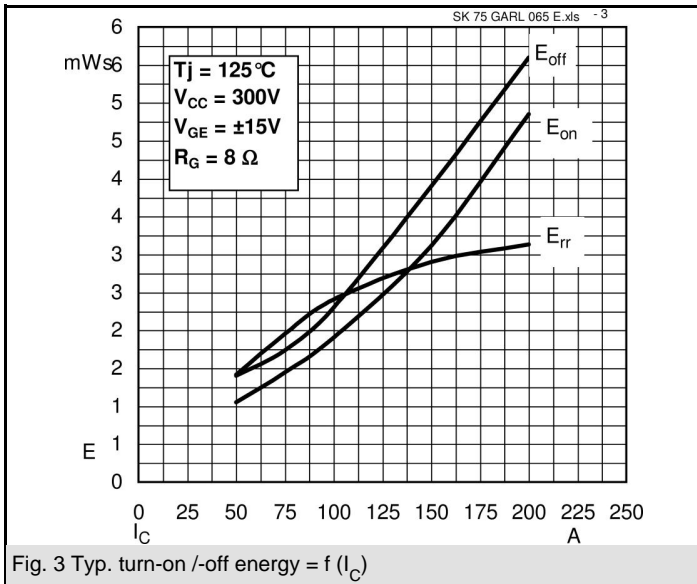
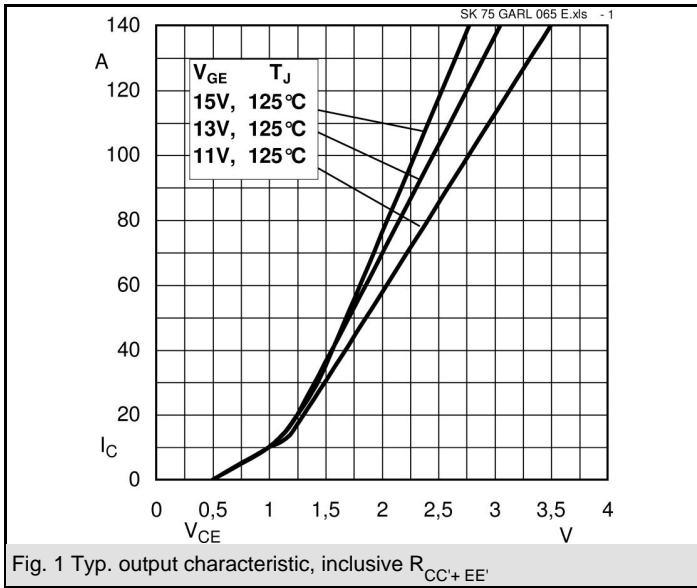


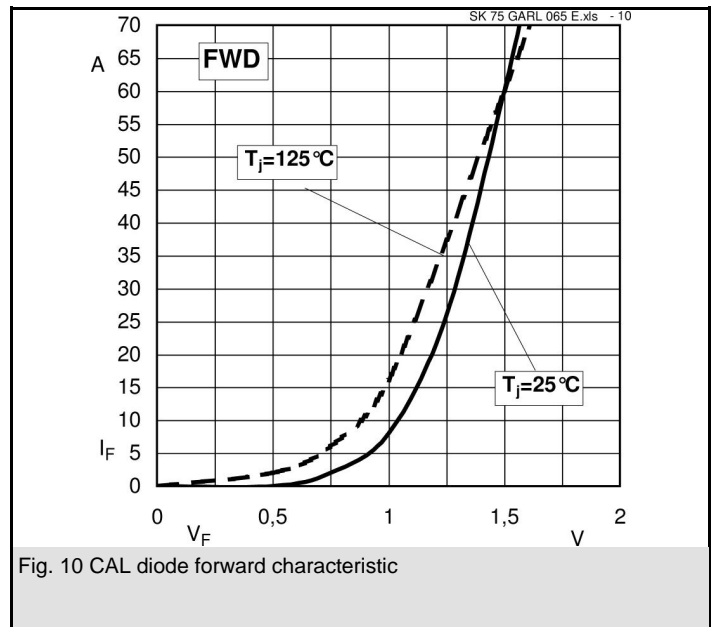
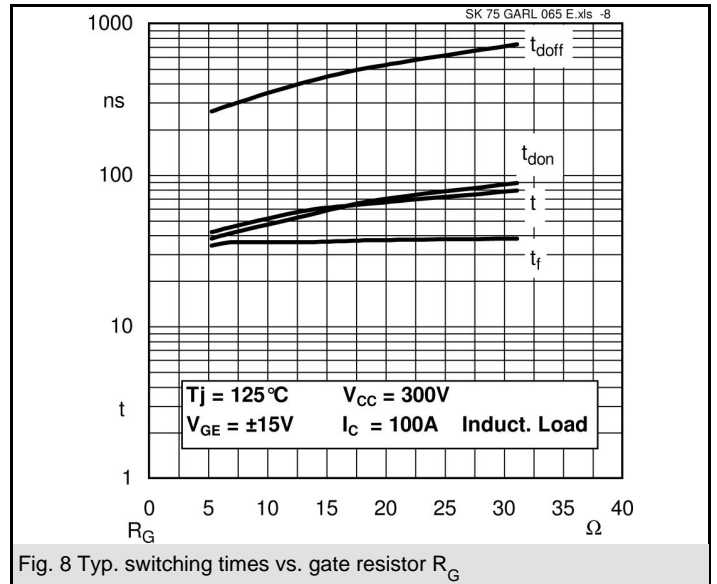
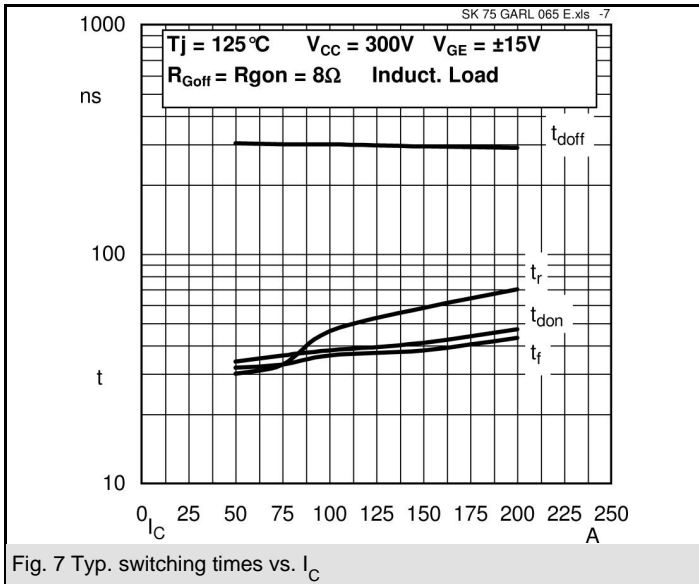
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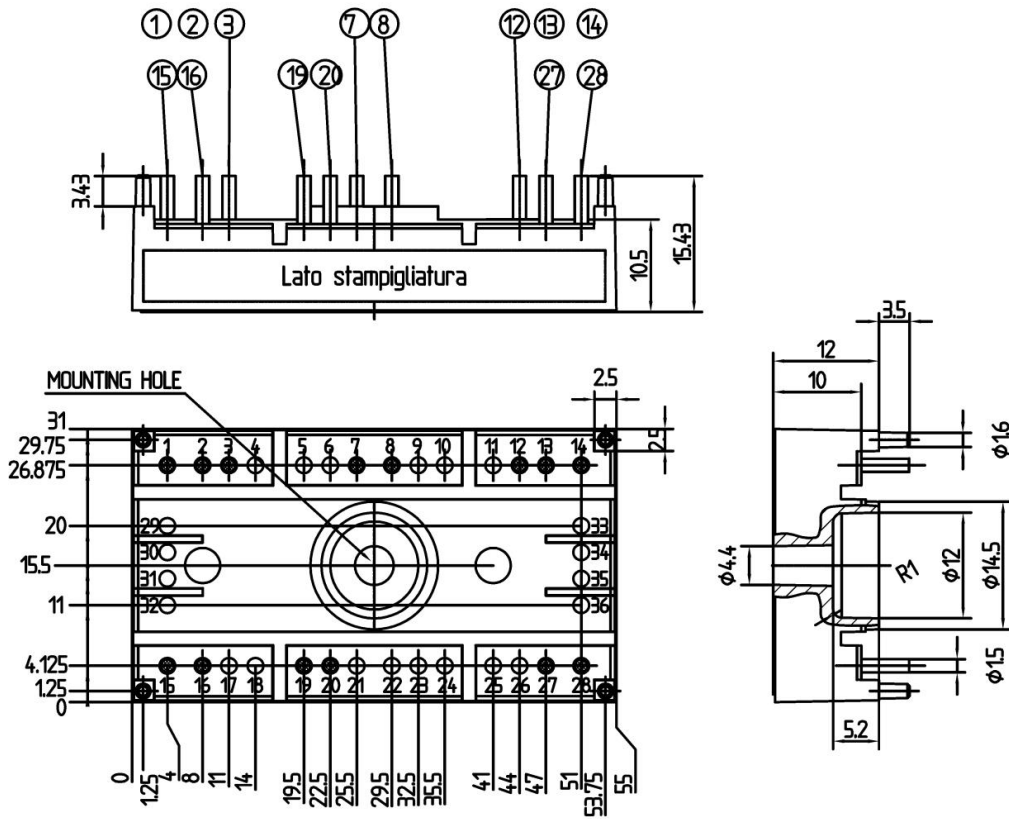
Characteristics				min.	typ.	max.	Units
Symbol	Conditions						
Inverse Diode							
$V_F = V_{EC}$	$I_{Fnom} = 30 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25 \text{ }^\circ\text{C}_{\text{chiplev.}}$		1,3	1,5		V
		$T_j = 125 \text{ }^\circ\text{C}_{\text{chiplev.}}$		1,2	1,45		V
V_{F0}		$T_j = 125 \text{ }^\circ\text{C}$		0,85	0,9		V
r_F		$T_j = 125 \text{ }^\circ\text{C}$		9	16		mΩ
I_{RRM}	$I_{Fnom} = 30 \text{ A}$	$T_j = 125 \text{ }^\circ\text{C}$		22			A
Q_{rr}	$di/dt = -500 \text{ A}/\mu\text{s}$			2,2			μC
E_{rr}	$V_{CC}=300\text{V}$			0,2			mJ
$R_{th(j-s)D}$	per diode					1,2	K/W
Freewheeling diode							
$V_F = V_{EC}$	$I_{Fnom} = 60 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25 \text{ }^\circ\text{C}_{\text{chiplev.}}$		1,45			V
		$T_j = 125 \text{ }^\circ\text{C}_{\text{chiplev.}}$		1,4			V
V_{F0}		$T_j = 125 \text{ }^\circ\text{C}$		0,85	0,9		V
r_F		$T_j = 125 \text{ }^\circ\text{C}$		5	9		V
I_{RRM}	$I_{Fnom} = 100 \text{ A}$	$T_j = 125 \text{ }^\circ\text{C}$		92			A
Q_{rr}	$di/dt = -9200 \text{ A}/\mu\text{s}$			39,1			μC
E_{rr}	$V_R=300\text{V}$			1,85			mJ
$R_{th(j-s)D}$	per diode					0,6	K/W
M_s	to heat sink			2,25		2,5	Nm
w					30		g

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

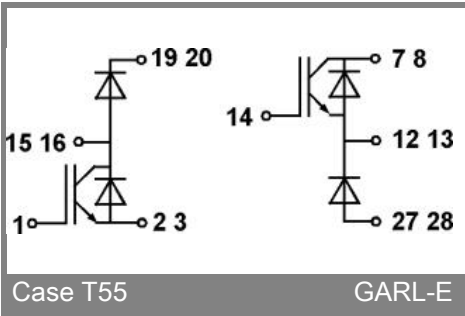
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Case T55 (Suggested hole diameter, in the PCB, for solder pins and plastic mounting pins: 2mm)



Case T55

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